

Test Procedure for the NCP5425 Single Output Evaluation Board

ON Semiconductor®



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1.0 Diagrams

1.1 Test Configuration

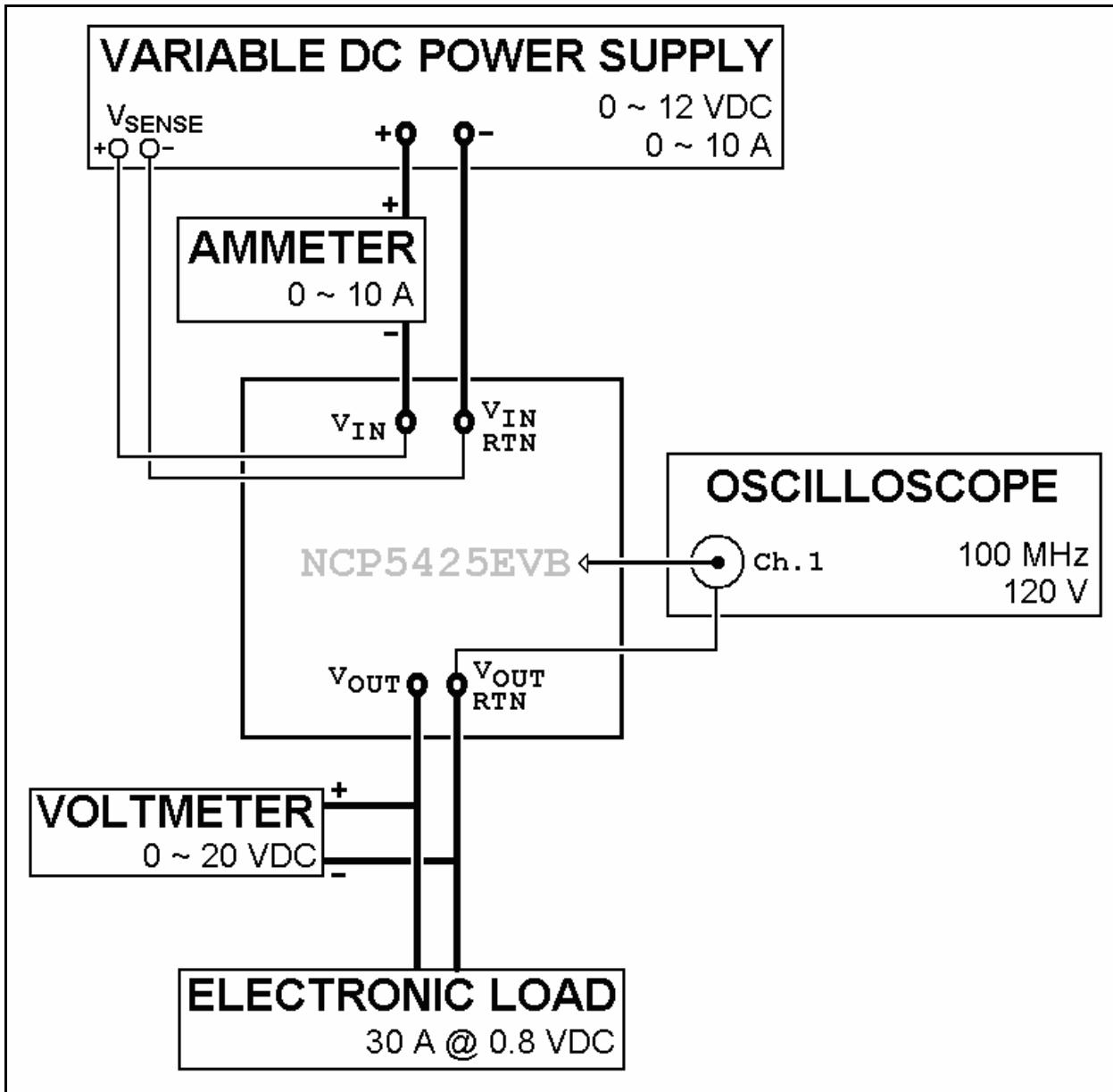


Figure 1. NCP5425EVB Single Output Test Configuration.

1.2 Test Points

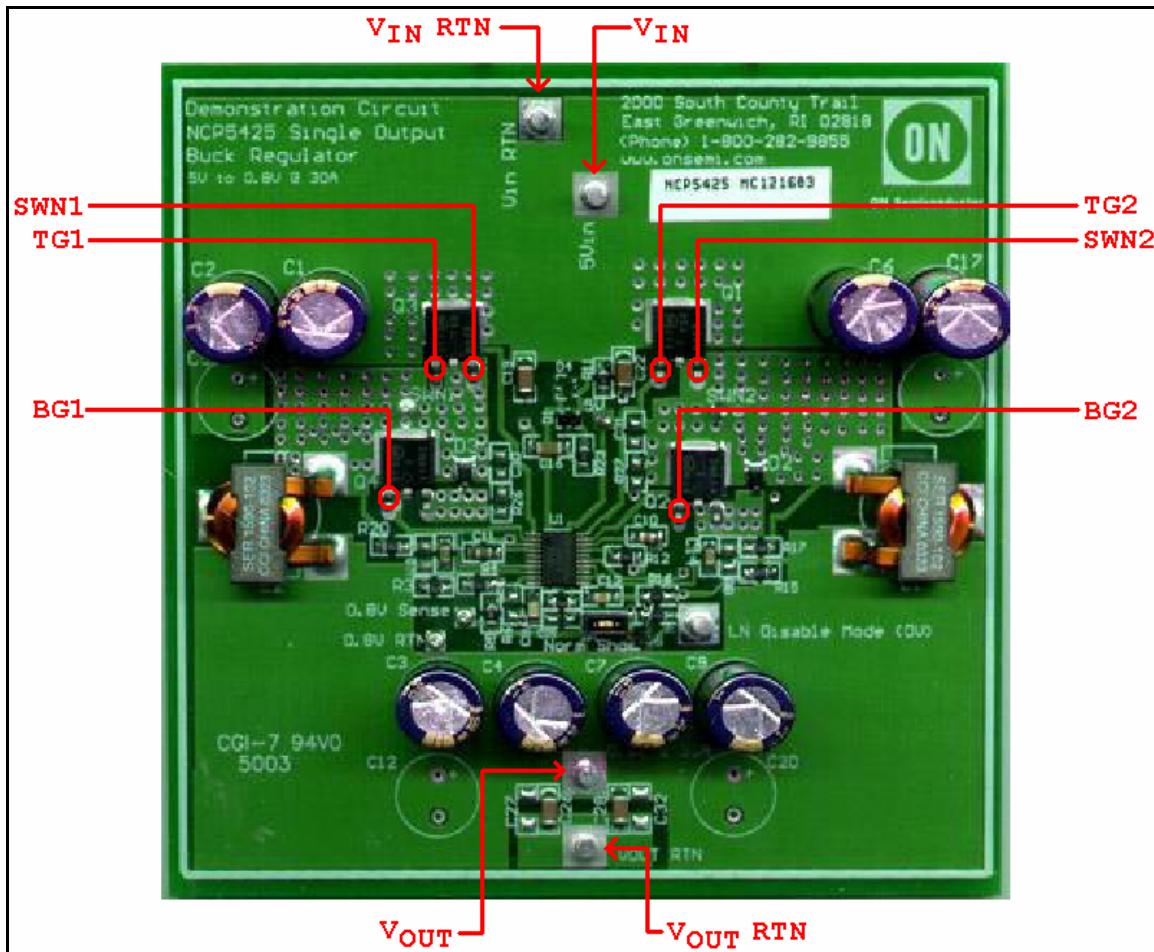


Figure 2. NCP5425EVB Single Output Test Points.

2.0 Equipment

- Variable DC power supply ($0 \sim 12$ V_{DC}, 10 A)
- Ammeter ($0 \sim 10$ A)
- Voltmeter ($0 \sim 20$ V_{DC})
- Electronic Load (capable of sinking 30 A at 0.8 V_{DC})
OR
Resistive Load (0.027Ω , 30 W)
- Oscilloscope (100 MHz, 120 V)

3.0 Procedure

- 3.1** Configure equipment as shown in Figure 1.
- 3.2** With no load connected, set supply current limit to 1.0 A. Increase supply voltage to 5.0 V, and verify that $V_{OUT} = 0.8 \text{ V} \pm 5.0\%$.
- 3.3** Increase supply current limit to 8.0 A. Apply full 30 A load. Verify again that $V_{OUT} = 0.8 \text{ V} \pm 5.0\%$.
- 3.4** Probe test points SWN1, TG1, BG1, SWN2, TG2, and BG2 with oscilloscope. Verify that the switching frequency is 224 – 376 kHz and that there is no excessive jitter.
- 3.5** Remove load. Briefly short V_{OUT} to V_{OUT} RTN. Verify that input current does not exceed 8.0 A and that output returns to regulation when short is removed.

4.0 Notes

- 4.1** The board should not produce audible noise during normal operation.
- 4.2** A parallel array of high-power resistors is recommended as a test load.